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Tel: +86-755-8981 8866 Fax: +86-755-8427 6832 Email & Skype: info@chipsmall.com Web: www.chipsmall.com Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China



Photocouplers GaAlAs Infrared LED & Photo IC

# TLP2962

### 1. Applications

- Factory Automation (FA)
- High-Speed Digital Interfacing
- Measuring Instruments

### 2. General

The Toshiba TLP2962 consists of a high-output GaAlAs light-emitting diode coupled with integrated high gain, high-speed photodetectors. The TLP2962 guarantees operation at up to 125 °C and on supplies from 2.7 V to 5.5 V. It is housed in the DIP8 package. The TLP2962 has an internal Faraday shield that provides a guaranteed common-mode transient immunity of 20 kV/ $\mu$ s.

### 3. Features

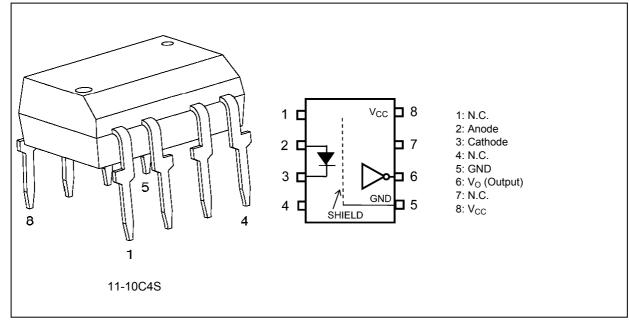
- (1) Inverter logic type (open collector output)
- (2) Package: DIP8
- (3) Operating temperature: -40 to 125 °C
- (4) Supply voltage: 2.7 to 5.5 V
- (5) Data transfer rate: 15 MBd (typ.) (NRZ)
- (6) Threshold input current: 5.0 mA (max)
- (7) Supply current: 4 mA (max)
- (8) Common-mode transient immunity:  $\pm 20 \text{ kV/}\mu s$  (min)
- (9) Isolation voltage: 5000 Vrms (min)
- (10) Safety standards
  - UL-approved: UL1577, File No.E67349

cUL-approved: CSA Component Acceptance Service No.5A File No.E67349

VDE-approved: EN60747-5-5 (Note 1)

Note 1: When an EN60747-5-5 approved type is needed, please designate the Option (D4).

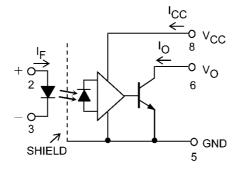
### 4. Packaging and Pin Configuration



Start of commercial production

2011-09

### 5. Internal Circuit



### 6. Principle of Operation

### 6.1. Truth Table

Input	LED	Output
Н	ON	L
L	OFF	Н

### 6.2. Mechanical Parameters

Characteristics	Min	Unit
Creepage distances	7.0	mm
Clearance distances	7.0	
Internal isolation thickness	0.4	

### 7. Absolute Maximum Ratings (Note) (Unless otherwise specified, $T_a = 25 °C$ )

	Characteristics		Symbol	Note	Rating	Unit
LED	Input forward current		١ <sub>F</sub>		20	mA
	Input forward current derating	(T <sub>a</sub> ≥ 116 °C)	$\Delta I_F / \Delta T_a$		-0.6	mA/°C
	Input forward current (pulsed)		I <sub>FP</sub>	(Note 1)	40	mA
	Input forward current derating (pulsed)	$(T_a \ge 110 \ ^\circ C)$	$\Delta I_{FP} / \Delta T_a$		-1.0	mA/°C
	Peak transient input forward current		I <sub>FPT</sub>	(Note 2)	1	A
	Peak transient input forward current derating	$(T_a \ge 110 \ ^\circ C)$	$\Delta I_{FPT} / \Delta T_a$		-25	mA/°C
	Input power dissipation		PD		40	mW
	Input power dissipation derating	$(T_a \ge 110 \ ^\circ C)$	$\Delta P_D / \Delta T_a$		-1.0	mW/°C
	Input reverse voltage		V <sub>R</sub>		5	V
Detector	Output current		Ι <sub>Ο</sub>		50	mA
	Output voltage		Vo		6	V
	Supply voltage		V <sub>CC</sub>		6	
	Output power dissipation		Po		85	mW
	Output power dissipation derating	(T <sub>a</sub> ≥ 110 °C)	$\Delta P_0 / \Delta T_a$		-2.1	mW/°C
Common	Operating temperature		T <sub>opr</sub>		-40 to 125	°C
	Storage temperature		T <sub>stg</sub>		-55 to 150	
	Lead soldering temperature	(10 s)	T <sub>sol</sub>		260	
	Isolation voltage	AC, 60 s, R.H. $\leq$ 60 %	BVS	(Note 3)	5000	Vrms

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: Pulse width (PW)  $\leq$  1 ms, duty = 50 %

Note 2: Pulse width (PW)  $\leq$  1  $\mu$ s, 300 pps

Note 3: This device is considered as a two-terminal device: Pins 1, 2, 3 and 4 are shorted together, and pins 5, 6, 7 and 8 are shorted together.

### 8. Recommended Operating Conditions (Note)

Characteristics	Symbol	Note	Min	Тур.	Max	Unit
Input on-state current	I <sub>F(ON)</sub>	(Note 1)	6.3	_	15	mA
Input off-state voltage	V <sub>F(OFF)</sub>		0	—	0.8	V
Supply voltage	V <sub>CC</sub>	(Note 2)	2.7	3.3/5.0	5.5	
Operating temperature	T <sub>opr</sub>	(Note 2)	-40	—	125	°C

Note: The recommended operating conditions are given as a design guide necessary to obtain the intended performance of the device. Each parameter is an independent value. When creating a system design using this device, the electrical characteristics specified in this datasheet should also be considered.

Note: A ceramic capacitor (0.1 µF) should be connected between pin 8 and pin 5 to stabilize the operation of a highgain linear amplifier. Otherwise, this photocoupler may not switch properly. The bypass capacitor should be placed within 1 cm of each pin.

Note 1: The rise and fall times of the input on-current should be less than 0.5  $\mu s.$ 

Note 2: Denotes the operating range, not the recommended operating condition.

#### 9. Electrical Characteristics (Note) (Unless otherwise specified, $T_a = -40$ to 125 °C, $V_{CC} = 2.7$ to 5.5 V)

Characteristics	Symbol	Note	Test Circuit	Test Condition	Min	Тур.	Max	Unit
Input forward voltage	V <sub>F</sub>		_	I <sub>F</sub> = 10 mA, T <sub>a</sub> = 25 °C	1.45	1.55	1.7	V
Input forward voltage temperature coefficient	$\Delta V_F / \Delta T_a$		_	I <sub>F</sub> = 10 mA	—	-2.0	—	mV/°C
Input reverse current	I <sub>R</sub>			V <sub>R</sub> = 5 V, T <sub>a</sub> = 25 °C	_		10	μA
Input capacitance	Ct			V = 0 V, f = 1 MHz, T <sub>a</sub> = 25 °C	—	60	_	pF
High-level output current	I <sub>ОН</sub>			V <sub>F</sub> = 0.8 V, V <sub>O</sub> = 5.5 V, V <sub>CC</sub> = 5.5 V	—		50	μΑ
				V <sub>F</sub> = 0.8 V, V <sub>O</sub> = 5.5 V, V <sub>CC</sub> = 5.5 V, T <sub>a</sub> = 25 °C	—		10	
Low-level output voltage	V <sub>OL</sub>		Fig. 12.1.2	I <sub>F</sub> = 5 mA I <sub>O</sub> = 13 mA (Sinking)	—	0.23	0.6	V
High-level supply current	I <sub>ССН</sub>		Fig. 12.1.3	I <sub>F</sub> = 0 mA	—	1.6	4.0	mA
Low-level supply current	I <sub>CCL</sub>		Fig. 12.1.4	I <sub>F</sub> = 10 mA	—	1.8	4.0	
Threshold input current (H/L)	I <sub>FHL</sub>			$I_{O} = 13 \text{ mA (Sinking)},$ $V_{O} < 0.6 \text{ V}, T_{a} = 25 ^{\circ}\text{C}$	_	1.3	2.8	
				I <sub>O</sub> = 13 mA (Sinking), V <sub>O</sub> < 0.6 V	_	_	5.0	

Note: All typical values are at  $T_a = 25$  °C.

### 10. Isolation Characteristics (Unless otherwise specified, $T_a = 25$ °C)

Characteristics	Symbol	Note	Test Conditions	Min	Тур.	Max	Unit
Total capacitance (input to output)	CS	(Note 1)	V <sub>S</sub> = 0 V, f = 1 MHz	_	1.0	_	pF
Isolation resistance	R <sub>S</sub>	(Note 1)	$V_S$ = 500 V, R.H. $\leq$ 60 %	1 × 10 <sup>12</sup>	10 <sup>14</sup>	_	Ω
Isolation voltage	BVS	(Note 1)	AC, 60 s	5000	—	_	Vrms
			AC, 1 s in oil		10000	_	
			DC, 60 s in oil		10000		Vdc

Note 1: This device is considered as a two-terminal device: Pins 1, 2, 3 and 4 are shorted together, and pins 5, 6, 7 and 8 are shorted together.

# 11. Switching Characteristics (Note) (Unless otherwise specified, $T_a = -40$ to 125 °C, $V_{CC} = 2.7$ to 5.5 V)

Characteristics	Symbol	Note	Test Circuit	Test Condition	Min	Тур.	Max	Unit
Propagation delay time (H/L)	t <sub>pHL</sub>	(Note 1)	Fig. 12.1.5	I <sub>F</sub> = 0→7.5 mA, R <sub>L</sub> = 350 Ω, C <sub>L</sub> = 15 pF	_	35	75	ns
Propagation delay time (L/H)	t <sub>pLH</sub>	(Note 1)		I <sub>F</sub> = 7.5→0 mA, R <sub>L</sub> = 350 Ω, C <sub>L</sub> = 15 pF	-	25	75	
Pulse width distortion	t <sub>pHL</sub> - t <sub>pLH</sub>	(Note 1)		$I_F$ = 7.5 mA, R <sub>L</sub> = 350 Ω, C <sub>L</sub> = 15 pF	_	—	35	
Propagation delay skew (device to device)	t <sub>psk</sub>	(Note 1), (Note 2)			-40	—	40	
Fall time	t <sub>f</sub>	(Note 1)		$I_F = 0 \rightarrow 7.5 \text{ mA}, R_L = 350 \Omega,$ $C_L = 15 \text{ pF}$	-	3	_	
Rise time	t <sub>r</sub>	(Note 1)		$I_F$ = 7.5 $\rightarrow$ 0 mA, R <sub>L</sub> = 350 $\Omega$ , C <sub>L</sub> = 15 pF	—	12	_	
Common-mode transient immunity at output high	СМ <sub>Н</sub>		Fig. 12.1.6	$V_{CM}$ = 1000 $V_{p-p}$ , $I_F$ = 0 mA, $V_{CC}$ = 3.3V / 5 V, $T_a$ = 25 °C	±20	±25	—	kV/μs
Common-mode transient immunity at output low	CML			$V_{CM} = 1000 V_{p-p}, I_F = 10 mA, V_{CC} = 3.3 V / 5 V, T_a = 25 °C$	±20	±25		

Note: All typical values are at  $T_a = 25$  °C.

Note 1: f = 5 MHz, duty = 50 %, input current  $t_r = t_f = 5$  ns,  $C_L$  is approximately 15 pF which includes probe and stray wiring capacitance.

Note 2: The propagation delay skew, t<sub>psk</sub>, is equal to the magnitude of the worst-case difference in t<sub>pHL</sub> and/or t<sub>pLH</sub> that will be seen between units at the same given conditions (supply voltage, input current, temperature, etc).

### 12. Test Circuits and Characteristics Curves

### 12.1. Test Circuits

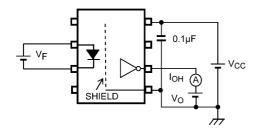
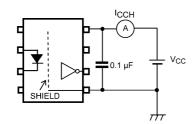


Fig. 12.1.1 I<sub>OH</sub> Test Circuit





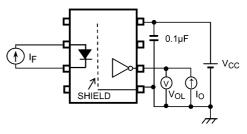


Fig. 12.1.2 V<sub>OL</sub> Test Circuit

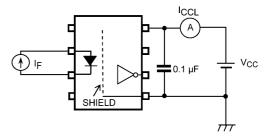
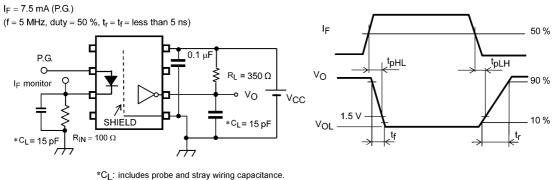
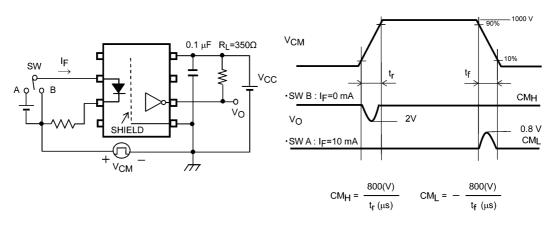


Fig. 12.1.4 I<sub>CCL</sub> Test Circuit



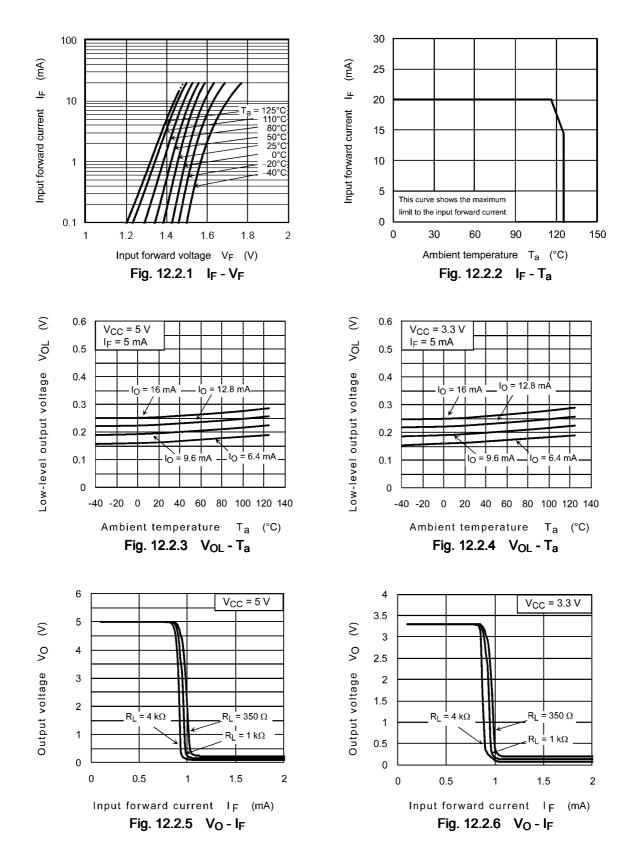
P.G.: Pulse Generator

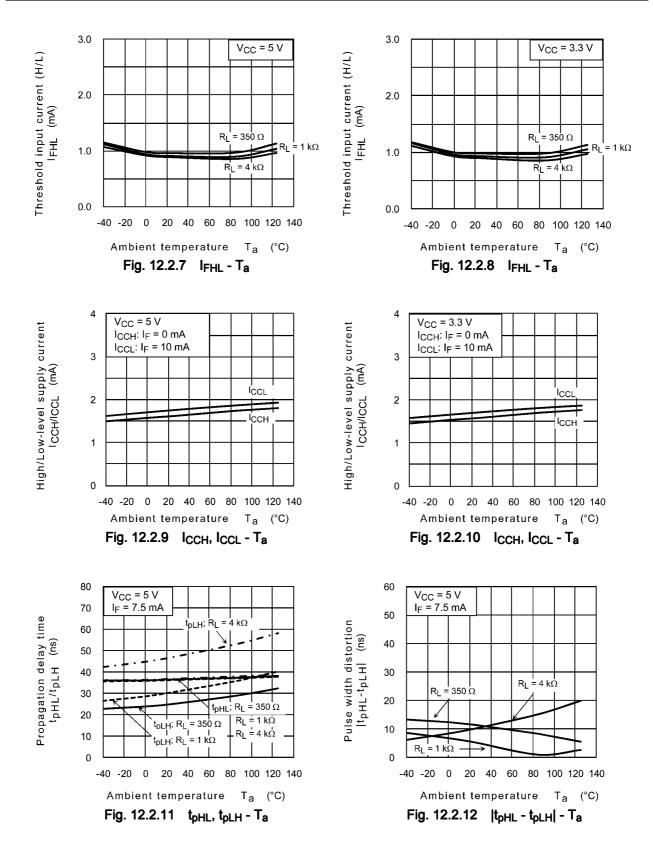


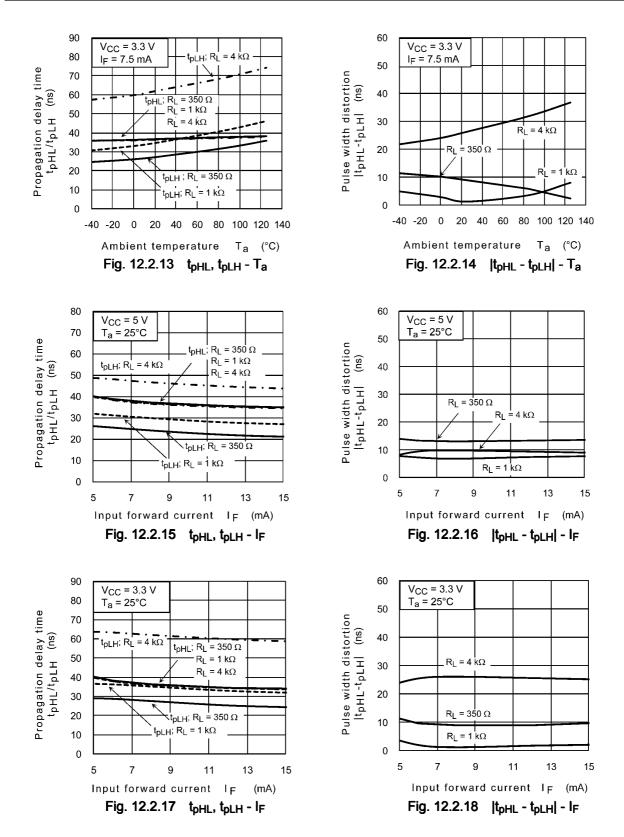




### 12.2. Characteristics Curves (Note)







Note: The above characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

### 13. Soldering and Storage

### 13.1. Precautions for Soldering

The soldering temperature should be controlled as closely as possible to the conditions shown below, irrespective of whether a soldering iron or a reflow soldering method is used.

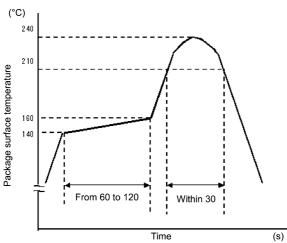
• When using soldering reflow.

The soldering temperature profile is based on the package surface temperature.

(See the figure shown below, which is based on the package surface temperature.)

Reflow soldering must be performed once or twice.

The mounting should be completed with the interval from the first to the last mountings being 2 weeks.



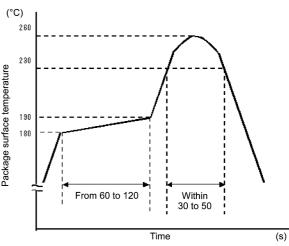
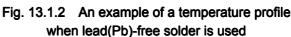


Fig. 13.1.1 An example of a temperature profile when Sn-Pb eutectic solder is used



When using soldering flow (Applicable to both eutectic solder and Lead(Pb)-Free solder)
Preheat the device at a temperature of 150 °C (package surface temperature) for 60 to 120 seconds.
Mounting condition of 260 °C within 10 seconds is recommended.
Flow coldering must be performed once

Flow soldering must be performed once. When using soldering Iron

Complete soldering within 10 seconds for lead temperature not exceeding 260 °C or within 3 seconds not exceeding 350 °C

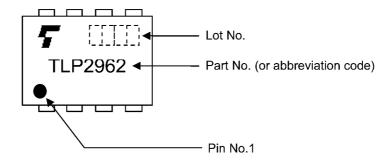
Heating by soldering iron must be done only once per lead.

#### 13.2. Precautions for General Storage

- Avoid storage locations where devices may be exposed to moisture or direct sunlight.
- Follow the precautions printed on the packing label of the device for transportation and storage.
- Keep the storage location temperature and humidity within a range of 5 °C to 35 °C and 45 % to 75 %, respectively.
- Do not store the products in locations with poisonous gases (especially corrosive gases) or in dusty conditions.
- Store the products in locations with minimal temperature fluctuations. Rapid temperature changes during storage can cause condensation, resulting in lead oxidation or corrosion, which will deteriorate the solderability of the leads.
- When restoring devices after removal from their packing, use anti-static containers.
- Do not allow loads to be applied directly to devices while they are in storage.
- If devices have been stored for more than two years under normal storage conditions, it is recommended that you check the leads for ease of soldering prior to use.



### 14. Marking



### 15. EN60747-5-5 Option (D4) Specification

- Part number: TLP2962 (Note 1)
- The following part naming conventions are used for the devices that have been qualified according to option (D4) of EN60747.

Example: TLP2962(D4,F)

D4: EN60747 option

F: [[G]]/RoHS COMPATIBLE (Note 2)

Note 1: Use TOSHIBA standard type number for safety standard application.

e.g., TLP2962(D4,F) → TLP2962

Note 2: Please contact your Toshiba sales representative for details on environmental information such as the product's RoHS compatibility.

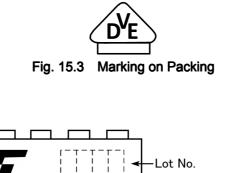
RoHS is the Directive 2011/65/EU of the European Parliament and of the Council of 8 June 2011 on the restriction of the use of certain hazardous substances in electrical and electronic equipment.

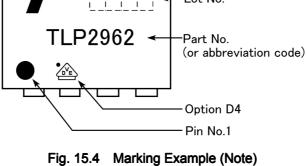
Description	Symbol	Rating	Unit
Application classification			
for rated mains voltage $\leq$ 600 Vrms for rated mains voltage $\leq$ 1000 Vrms		I-IV I-III	_
Climatic classification		55 / 125 / 21	_
Pollution degree		2	_
Maximum operating insulation voltage	VIORM	890	Vpeak
Input to output test voltage, Method A $V_{pr} = 1.6 \times V_{IORM}$ , type and sample test $t_p = 10$ s, partial discharge < 5 pC	Vpr	1424	Vpeak
Input to output test voltage, Method B $V_{pr} = 1.875 \times V_{IORM}$ , 100 % production test $t_p = 1$ s, partial discharge < 5 pC	Vpr	1670	Vpeak
Highest permissible overvoltage (transient overvoltage, t <sub>pr</sub> = 60 s)	VTR	8000	Vpeak
Safety limiting values (max. permissible ratings in case of fault, also refer to thermal derating curve) current (input current IF, P <sub>so</sub> = 0) power (output or total power dissipation) temperature	lsi Pso Ts	300 500 150	mA mW °C
Insulation resistance $V_{IO} = 500 \text{ V}, \text{ T}_{a} = 25 ^{\circ}\text{C}$ $V_{IO} = 500 \text{ V}, \text{ T}_{a} = 100 ^{\circ}\text{C}$ $V_{IO} = 500 \text{ V}, \text{ T}_{a} = \text{T}_{s}$	Rsi	≥ 10 <sup>12</sup> ≥ 10 <sup>11</sup> ≥ 10 <sup>9</sup>	Ω

Fia. 15.1	EN60747	Isolation	Characteristics
go		100101011	

Minimum creepage distance	Cr	7.0 mm
Minimum clearance	CI	7.0 mm
Minimum insulation thickness	ti	0.4 mm
Comparative tracking index	CTI	175

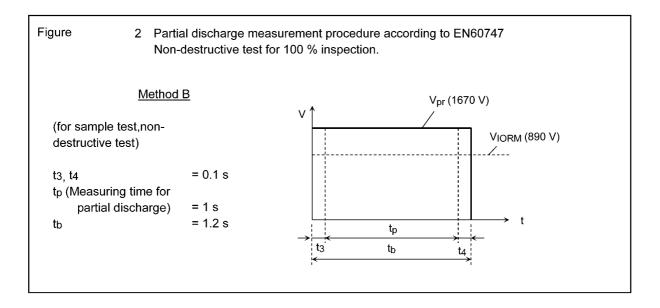
Note: This photocoupler is suitable for **safe electrical isolation** only within the safety limit data. Maintenance of the safety data shall be ensured by means of protective circuits.

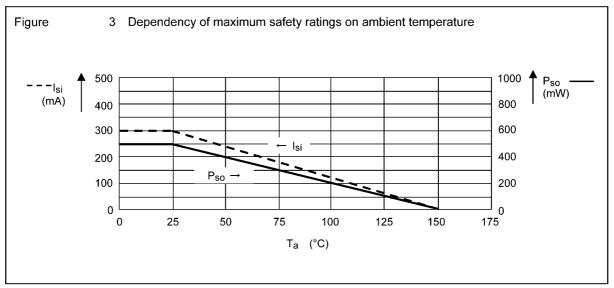




Note: The above marking is applied to the photocouplers that have been qualified according to option (D4) of EN60747.

5	-	surement procedure according to EN60747 alification and sampling tests.
Method	<u>A</u>	VINITIAL (8 KV)
(for type and sampling t destructive tests)	ests,	V V Vpr (1424 V)
t1, t2	= 1 to 10 s	VIORM (890 V)
t3, t4	= 1 s	
tp (Measuring time for		
partial discharge)	= 10 s	$0 \xrightarrow{I} \qquad \qquad$
tb	= 12 s	$t_3$ $t_p$ $t_4$
tini	= 60 s	t1 tini t2 to





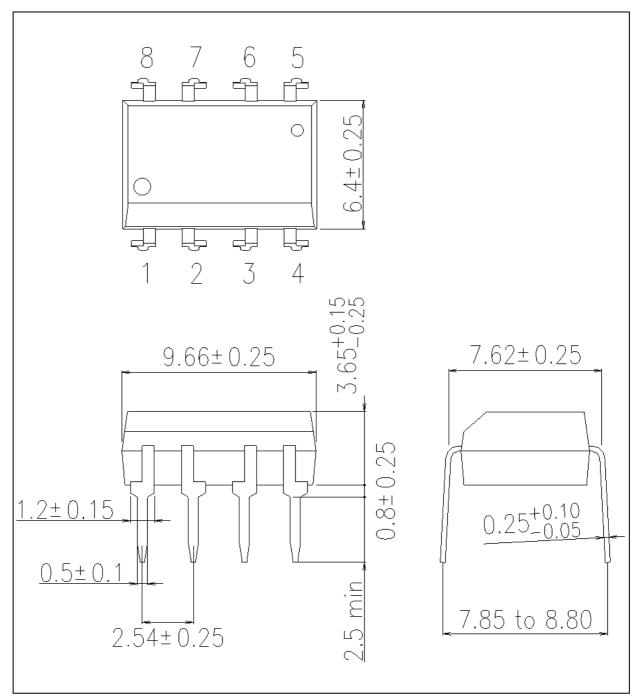




### Package Dimensions

TLP2962

Unit: mm



Weight: 0.54 g (typ.)

Package Name(s) TOSHIBA: 11-10C4S

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